

NOT RECOMMENDED FOR NEW DESIGN - NO ALTERNATE PART



DMG4712SSS

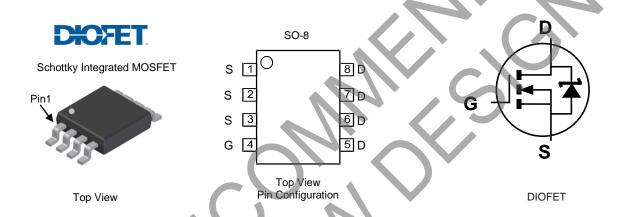
N-CHANNEL ENHANCEMENT MODE MOSFET WITH SCHOTTKY DIODE

Features

- High Density UMOS with Schottky Barrier Diode
- Low Leakage Current at High Temperature
- High Conversion Efficiency
- Low On-Resistance
- Low Input Capacitance
- Fast Switching Speed
- Utilizes Diodes Incorporated's Monolithic DIOFET Technology to Increase Conversion Efficiency
- UIS Tested, R_G Tested
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

Mechanical Data

- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound.
 UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram Below
- Terminals: Finish Tin Finish Annealed over Copper Leadframe.
 Solderable per MIL-STD-202, Method 208 (23)
- Weight: 0.074 grams (Approximate)



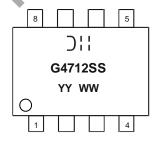
Ordering Information (Note 4)

Part Number	Case	Packaging
DMG4712SSS-13	SO-8	2.500 / Tape & Reel

Notes: 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.

- 2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/.

Marking Information



⊃¦¦ = Manufacturer's Marking G4712SS = Product Type Marking Code YYWW = Date Code Marking YY or YY = Year (ex: 18 = 2018) WW = Week (01 to 53)



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Maximum Ratings (@T_A = +25°C, unless otherwise specified.)

Chara	Symbol	Value	Unit		
Drain-Source Voltage	Drain-Source Voltage			30	V
Gate-Source Voltage			V _{GSS}	±12	V
Continuous Drain Current (Note 5)	Steady State	TA = +25°C TA = +85°C	I _D	11.2 6.6	А
Pulsed Drain Current (Note 6)	I _{DM}	63	Α		
Avalanche Current (Notes 6 & 7)			I _{AR}	30	Α
Repetitive Avalanche Energy (Notes 6 & 7) L = 0.1mH			E _{AR}	45	mJ

Thermal Characteristics

Characteristic	Symbol	Value	Unit
Power Dissipation (Note 5)	P _D	1.55	W
Thermal Resistance, Junction to Ambient @T _A = +25°C (Note 5)	ReJA	81.3	°C/W
Operating and Storage Temperature Range	TJ, TSTG	-55 to +150	°C

Electrical Characteristics (@ T_A = +25°C, unless otherwise stated.)

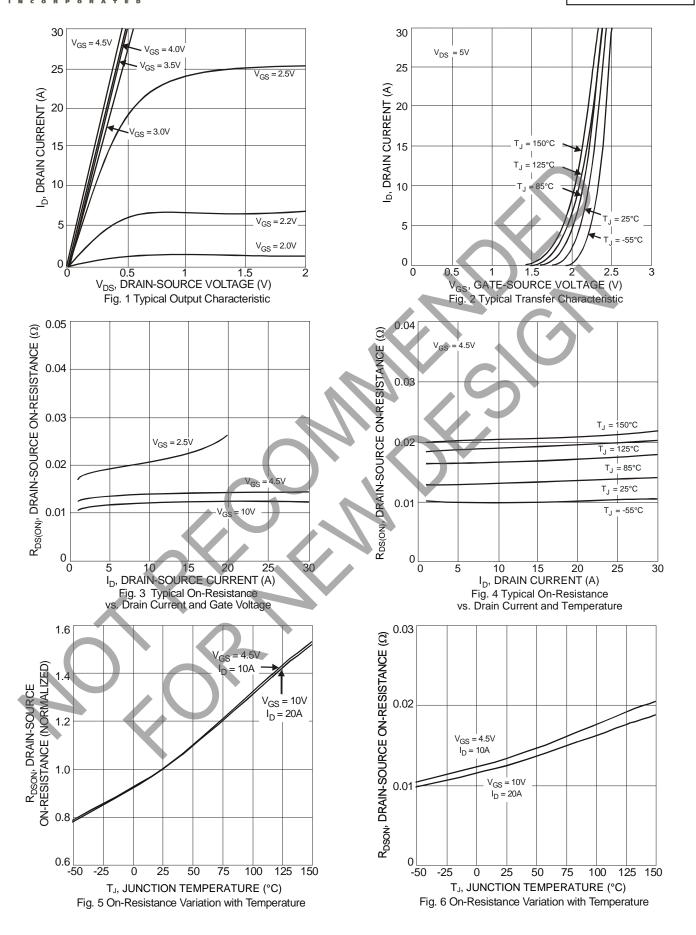
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 8)	7		- 71-			
Drain-Source Breakdown Voltage	BV _{DSS}	30	- <	-	V	$V_{GS} = 0V$, $I_D = 1mA$
Zero Gate Voltage Drain Current	IDSS	Y-		100	μA	V _{DS} = 30V, V _{GS} = 0V
Gate-Source Leakage	Igss	-	-	±100	nA	$V_{GS} = \pm 12V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 8)						
Gate Threshold Voltage	V _{GS(TH)}	1.0		2.2	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
Static Drain-Source On-Resistance			10	14.0	mΩ	$V_{GS} = 10V, I_D = 11.2A$
Static Drain-Source Off-Resistance	R _{DS(ON)}		11	15.4	11122	$V_{GS} = 4.5V, I_D = 10A$
Forward Transfer Admittance	Yfs	-	23	-	S	$V_{DS} = 5V, I_{D} = 11.2A$
Diode Forward Voltage	V _{SD}	-	0.37	0.55	V	$V_{GS} = 0V, I_{S} = 1A$
Maximum Body-Diode + Schottky Continuous Current	lş	7	-	5	Α	-
DYNAMIC CHARACTERISTICS (Note 9)						
Input Capacitance	Ciss	-	2,296	-	рF	\\\\ 45\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\
Output Capacitance	Coss	-	164	-	рF	$V_{DS} = 15V, V_{GS} = 0V,$ f = 1.0MHz
Reverse Transfer Capacitance	C _{rss}	-	120	-	рF	1 = 1.01/11/12
Gate Resistance	Rg	-	1.3	-	Ω	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$
Total Gate Charge (V _{GS} = 10V)	Q_g	-	45.7	-	nC	
Total Gate Charge (V _{GS} = 4.5V)	Qg	-	19.3	-	nC	\\\ 45\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\
Gate-Source Charge	Qgs	-	5.0		nC	$V_{DS} = 15V, I_{D} = 11.2A$
Gate-Drain Charge	Q _{gd}	-	2.9	-	nC	
Turn-On Delay Time	t _{D(ON)}	-	5.5	-	ns	
Turn-On Rise Time	t _R	-	24.4	-	ns	$V_{GS} = 10V, V_{DS} = 15V,$
Turn-Off Delay Time	t _{D(OFF)}	-	33.1	-	ns	$R_G = 3\Omega$, $R_L = 1.2\Omega$
Turn-Off Fall Time	t _F	-	6.6	-	ns	

5. Device mounted on FR-4 PCB with minimum recommended pad layout. The value in any given application depends on the user's specific board design.

S. Device included on FR-4 PCB with miniminal recommended pad rayout. The value in any given application depends on the user's specific board design.
 Repetitive rating, pulse width limited by junction temperature.
 I_{AR} and E_{AR} ratings are based on low frequency and duty cycles to keep T_J = +25°C. L = 0.1mH, V_{DD} = 0V, R_G = 0Ω, rated V_{DS} = 30V, and V_{GS} = 10V.
 Short duration pulse test used to minimize self-heating effect.
 Guaranteed by design. Not subject to product testing.

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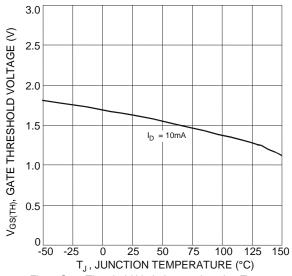
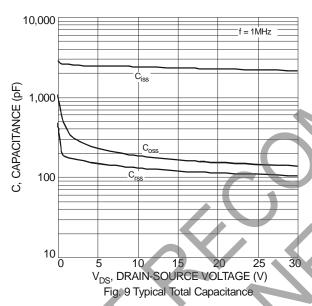
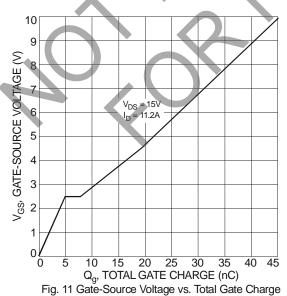
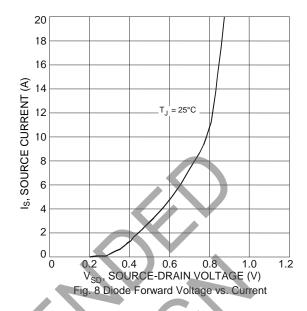
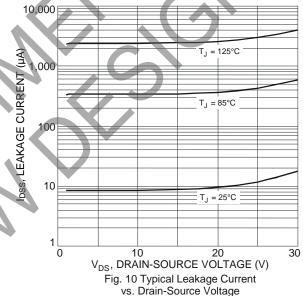


Fig. 7 Gate Threshold Variation vs. Junction Temperature

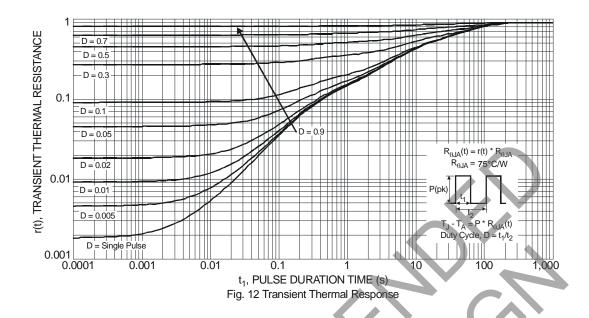






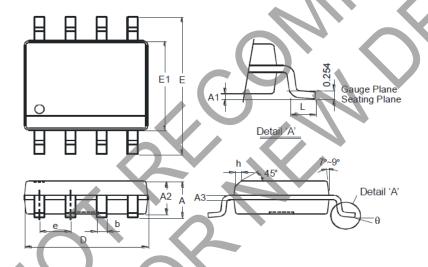






Package Outline Dimensions

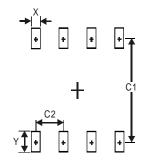
Please see http://www.diodes.com/package-outlines.html for the latest version.



SO-8						
Dim	Min	Max				
Α	-	1.75				
A1	0.10	0.20				
A2	1.30	1.50				
A3	0.15	0.25				
b	0.3	0.5				
O	4.85	4.95				
E	5.90	6.10				
E1	3.85	3.95				
е	e 1.27 Typ					
h	-	0.35				
٦	0.62	0.82				
θ	0°	8°				
All Dimensions in mm						

Suggested Pad Layout

Please see http://www.diodes.com/package-outlines.html for the latest version.



Dimensions	Value (in mm)			
Х	0.60			
Υ	1.55			
C1	5.4			
C2	1.27			



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